

# AOK53S60-VB Datasheet N-Channel 600 V (D-S) Super Junction Power MOSFET

| PRODUCT SUMMA                              | RY                     |       |
|--|------------------------|-------|
| V <sub>DS</sub> (V) at T <sub>J</sub> max. | 600                    | )     |
| R <sub>DS(on)</sub> at 25 °C (Ω)           | V <sub>GS</sub> = 10 V | 0.060 |

## **FEATURES**

 $\bullet$  Low figure-of-merit (FOM)  $R_{on}\,x\,Q_g$ 



- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)

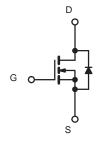
## **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- - High-intensity discharge (HID)
  - Fluorescent ballast lighting

TO-247







N-Channel MOSFET

| PARAMETER  |                         |   | SYMBOL                            | LIMIT       | UNIT  |
|--|-------------------------|---|-----------------------------------|-------------|-------|
| Drain-Source Voltage                               |                         |   | $V_{DS}$                          | 600         |       |
| Gate-Source Voltage                                |                         |   | $V_{GS}$                          | ± 30        | - V   |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) | V <sub>GS</sub> at 10 V | $T_{\rm C} = 25  ^{\circ}{\rm C}$<br>$T_{\rm C} = 100  ^{\circ}{\rm C}$ | I-                                | 47          |       |
| Continuous Drain Current (1) = 150 C)              | VGS at 10 V             | T <sub>C</sub> = 100 °C   | ID                                | 29          | Α     |
| Pulsed Drain Current <sup>a</sup>                  |                         |   | I <sub>DM</sub>                   | 140         |       |
| Linear Derating Factor                             |                         |   |                                   | 1.67        | W/°C  |
| Single Pulse Avalanche Energy b                    |                         |   | E <sub>AS</sub>                   | 850         | mJ    |
| Maximum Power Dissipation                          |                         |   | P <sub>D</sub>                    | 510         | W     |
| Operating Junction and Storage Temperature Range   |                         |   | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | °C    |
| Drain-Source Voltage Slope                         | T <sub>J</sub> = 125 °C |   | 4).//d+                           | 50          | 1//20 |
| Reverse Diode dV/dt d                              | •                       |   | dV/dt                             | 15          | V/ns  |
| Soldering Recommendations (Peak Temperature) c     | for                     | 10 s  |                                   | 260         | °C    |

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=100~V$ , starting  $T_J=25~^{\circ}C$ , L=30mH,  $R_g=25~\Omega$ ,  $I_{AS}=24A$ . c. 1.6 mm from case.

- d.  $I_{SD} \le I_D$ , dI/dt = 100 A/ $\mu$ s, starting  $T_J = 25$  °C.



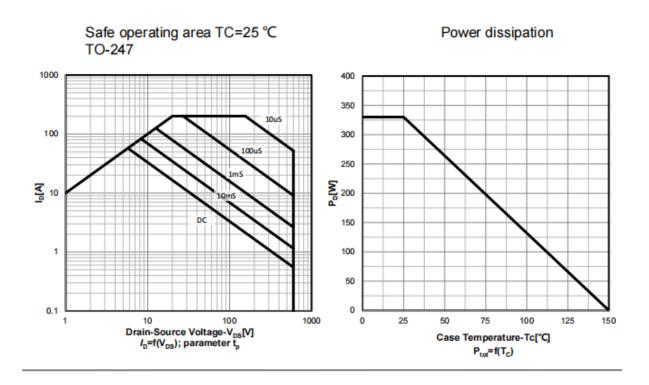
| THERMAL RESISTANCE RATI          | NGS               |      |      |      |
|----------------------------------|-------------------|------|------|------|
| PARAMETER                        | SYMBOL            | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient      | R <sub>thJA</sub> | -    | 62   | °C/W |
| Maximum Junction-to-Case (Drain) | $R_{thJC}$        | -    | 0.38 | C/VV |

| PARAMETER   | SYMBOL                | TEST CONDITIONS  |   |     | TYP.  | MAX.  | UNIT |
|---|-----------------------|--|---|-----|-------|-------|------|
| Static  |                       | -  |   |     |       |       | •    |
| Drain-Source Breakdown Voltage                            | V <sub>DS</sub>       | V <sub>GS</sub> :  | = 0 V, I <sub>D</sub> = 1 mA                      | 600 | -     | -     | V    |
| V <sub>DS</sub> Temperature Coefficient                   | $\Delta V_{DS}/T_{J}$ | Reference  | e to 25 °C, I <sub>D</sub> = 1 mA                 | -   | 0.70  | -     | V/°C |
| Gate-Source Threshold Voltage (N)                         | V <sub>GS(th)</sub>   | V <sub>DS</sub> =  | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA       | 2.5 | -     | 4.5   | V    |
|   |                       |  | V <sub>GS</sub> = ± 20 V                          | -   | -     | ± 100 | nA   |
| Gate-Source Leakage                                       | $I_{GSS}$             |  | V <sub>GS</sub> = ± 30 V                          | _   | -     | ± 1   | μA   |
|   |                       |  | = 600V, V <sub>GS</sub> = 0 V                     | _   | -     | 1     |      |
| Zero Gate Voltage Drain Current                           | I <sub>DSS</sub>      |  | V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C | -   | -     | 100   | μA   |
| Drain-Source On-State Resistance                          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V   | I <sub>D</sub> =16A                               | -   | 0.060 | -     | Ω    |
| Forward Transconductance                                  | 9 <sub>fs</sub>       | V <sub>DS</sub> = 30 V, I <sub>D</sub> = 16 A  |   | -   | 5.6   | -     | S    |
| Dynamic   |                       |  |   |     |       |       |      |
| Input Capacitance   | C <sub>iss</sub>      | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 100 V,<br>f = 1 MHz  |   | -   | 4900  | -     | pF   |
| Output Capacitance  | Coss                  |  |   | -   | 330   | -     |      |
| Reverse Transfer Capacitance                              | C <sub>rss</sub>      |  |   | -   | 4     | -     |      |
| Effective Output Capacitance, Energy Related <sup>a</sup> | C <sub>o(er)</sub>    | - V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V  |   | -   | 63    | -     |      |
| Effective Output Capacitance, Time Related <sup>b</sup>   | C <sub>o(tr)</sub>    |  |   | -   | 213   | -     |      |
| Total Gate Charge   | Qg                    |  |   | _   | 370   | -     |      |
| Gate-Source Charge  | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V   | $I_D = 20 \text{ A}, V_{DS} = 520 \text{ V}$      | -   | 3 9   |       | nC   |
| Gate-Drain Charge   | Q <sub>gd</sub>       | 1  |   | -   | 4 7   | -     |      |
| Turn-On Delay Time  | t <sub>d(on)</sub>    | V <sub>DD</sub> = 520 V, I <sub>D</sub> = 20A,   |   | -   | 18    | 25    | ns   |
| Rise Time   | t <sub>r</sub>        |  |   | -   | 24    | 55    |      |
| Turn-Off Delay Time                                       | t <sub>d(off)</sub>   |  |   | -   | 8 0   | ı     | 115  |
| Fall Time   | t <sub>f</sub>        | $V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$  |   | -   | 1 2   | -     |      |
| Gate Input Resistance                                     | $R_{g}$               | f = 1 MHz, open drain  |   | -   | 0.8   | -     | Ω    |
| <b>Drain-Source Body Diode Characteristic</b>             | s                     |  |   |     |       |       |      |
| Continuous Source-Drain Diode Current                     | I <sub>S</sub>        | MOSFET symbol showing the integral reverse p - n junction diode  |   | -   | -     | 47    |      |
| Pulsed Diode Forward Current                              | I <sub>SM</sub>       |  |   | -   | -     | 140   | - A  |
| Diode Forward Voltage                                     | V <sub>SD</sub>       | T <sub>J</sub> = 25 °  | C, I <sub>S</sub> = 8 A, V <sub>GS</sub> = 0 V    | -   | -     | 1.5   | V    |
| Reverse Recovery Time                                     | t <sub>rr</sub>       |  |   | -   | 520   | -     | ns   |
| Reverse Recovery Charge                                   | Q <sub>rr</sub>       | T <sub>J</sub> = 25 °C, I <sub>F</sub> = I <sub>S</sub> = 8 A,<br>dl/dt = 100 A/μs, V <sub>R</sub> = 400 V |   | -   | 5.8   | -     | μC   |
| Reverse Recovery Current                                  | I <sub>RRM</sub>      |  |   |     | 4 5   | _     | A    |

## Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .





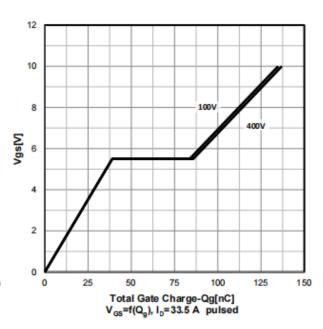
Typ. output characteristics  $T_i$ =25  $^{\circ}$ C Transfer characteristics 300 300 25°C . I<sub>D</sub>, Drain Current [A] Drain Current [A] 200 150°C -0 0 5 10 15 20 0 2 10 12 V<sub>GS</sub>, Gate-Source Voltage [V] V<sub>DS</sub>, Drain to Source Voltage [V]



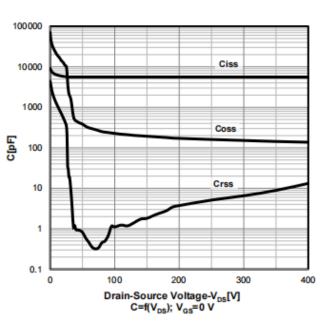
Typ. drain-source on-state resistance

80
70
60
60
40
30
20
0 15 30 45 60 75 90
Drain-Source Current-I<sub>D</sub>[A]
R<sub>DS</sub>(on)=f(I<sub>D</sub>); parameter:V<sub>GS</sub>

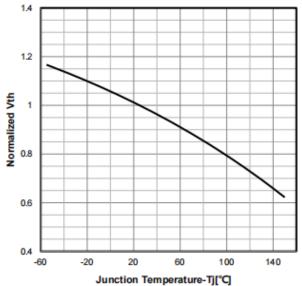
Typ. gate charge characteristics



Typ. capacitances



# Normalized $V_{\text{GS(th)}}$ characteristics

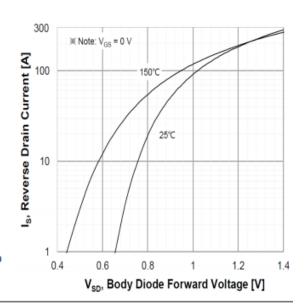




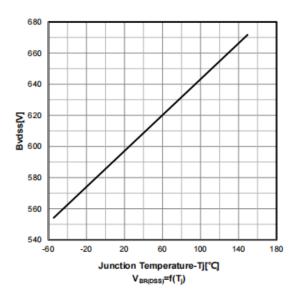
## On-resistance vs temperature

# 120 100 80 40 40 40 Typ 40 Junction Temperature-Tj[°C] R<sub>DS</sub>(on)=f(T<sub>j</sub>); I<sub>D</sub>=33.5 A; V<sub>GS</sub>=10 V

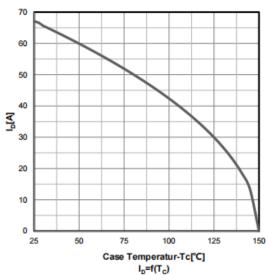
## Forward characteristics of reverse diode



## Drain-source breakdown voltage



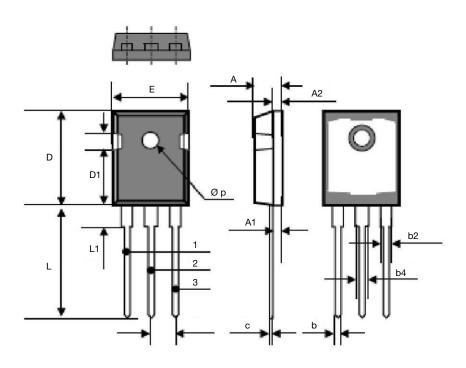
## Drain current vs temperature



服务热线:400-655-8788 5



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| DIM. | MILLIN | METERS   | INCHES |           |  |
|------|--------|----------|--------|-----------|--|
|      | MIN.   | MAX.     | MIN.   | MAX.      |  |
| А    | 4.70   | 5.31     | 0.185  | 0.209     |  |
| A1   | 2.21   | 2.59     | 0.087  | 0.102     |  |
| A2   | 1.50   | 2.49     | 0.059  | 0.098     |  |
| b    | 0.99   | 1.40     | 0.039  | 0.055     |  |
| b2   | 1.65   | 2.41     | 0.065  | 0.095     |  |
| b4   | 2.59   | 3.43     | 0.102  | 0.135     |  |
| С    | 0.61   | 0.61 BSC |        | 0.024 BSC |  |
| D    | 20.80  | 21.46    | 0.819  | 0.845     |  |
| D1   | 3.68   | 5.49     | 0.145  | 0.216     |  |
| (e)  | 5.46   | BSC      | 0.215  | BSC       |  |
| E    | 15.49  | 16.26    | 0.610  | 0.640     |  |
| L    | 19.81  | 20.32    | 0.780  | 0.800     |  |
| L1   | 4.06   | 4.50     | 0.160  | 0.177     |  |
| Øр   | 3.51   | 3.66     | 0.138  | 0.144     |  |



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